Notice of References Cited	Application/Control No. 10/682,640	Applicant(s)/Patent Under Reexamination YOTANI ET AL.	
	Examiner Kevin M. Nguyen	Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,991,949	01-2006	Muroyama et al.	438/20
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP08-185816	07-2002	Japan	Ogawa et al.	H01J 31/12
	O	JP2002-203469	07-1996	Japan	Fukuda et al.	H01J 1/304
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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